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## Amorphous Gallium Oxide Thin Film Grown by Atomic Layer Deposition for High-Performance and Flexible Deep-Ultraviolet Photodetector

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## **Extended Abstract**

Deep-ultraviolet (DUV) light with a wavelength ( $\lambda$ ) of 200~300 nm has been spotlighted for the photolysis, water or air purification. Interestingly, DUV light does not exist on the earth surface naturally, because DUV coming from the sun is absorbed by ozone in the atmosphere.[1] Thus, DUV can be used for communication or missile tracking thanks to a weak background interference. For those applications, a development of high-performance DUV photodetector is necessary.[2] DUV detection is also important for sensing biological molecules because some of biological molecules absorption and florescence spectrum is within the range of DUV wavelength.[3] In the meantime, DUV light is dangerous and harmful to human body because of its high energy (>4 eV). Therefore, the development of high-performance DUV photodetector is required such as AlGaN. Unfortunately, most of existing DUV photodetectors exhibited a poor performance in the DUV detection despite the use of the epitaxial AlGaN layer.[4] In addition, the growth of epitaxial AlGaN layer must be done at high temperature

(>1000 °C) using complex buffer layers. Ga<sub>2</sub>O<sub>3</sub> is a good candidate for the DUV detection because of its wide bandgap (~5

eV), however, photodetectors using epitaxial Ga<sub>2</sub>O<sub>3</sub> films exhibited a slow response speed with low responsivity.[5] Here, we demonstrated a high-performance DUV photodetector using an amorphous gallium oxide thin films (GaO<sub>x</sub>) grown by atomic layer deposition (ALD) at a low growth temperature of <250 °C for the first time. Interestingly, the amorphous GaO<sub>x</sub> showed a wide bandgap of (~4.9 eV) which is comparable with epitaxial Ga<sub>2</sub>O<sub>3</sub> films. The photodetector using 30-nm-thick amorphous GaO<sub>x</sub> film showed a fast response (as short as ~3 us) with high responsivity (~45 A/W at  $\lambda$  = 253 nm) which outperforms conventional DUV photodetectors. The cut-off wavelength is ~ 300 nm that does not respond to visible lights, and the photodetector detects only DUV wavelengths selectively. It should be noted that general substrates such as a glass and quartz can be used for the DUV photodetector owing to the amorphous phase of GaO<sub>x</sub> film, which enables a practical application of the fabrication protocol. Finally, we demonstrated a flexible DUV photodetector fabricated on polyimide substrate which showed a reliable detection of DUV with the repetitive bending cycles beyond >3000 times at a bending radius of <10 mm. Interestingly, the performance was maintained under the bending radius of <2 mm by a stress engineering. This process scheme will provide an economically useful solution for the development of DUV sensor for various applications.

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